

Form PTO-1449 U.S. DEPARTMENT OF COMMERCE (REV. 7-80) PATENT AND TRADEMARK OFFICE  <b>LIST OF REFERENCES CITED BY APPLICANT</b>  (Use several sheets if necessary)		<b>Atty. Dock t N .</b> END920030090US1 (16992)		<b>S rial N .</b> 10/776,901 <del>Unassigned</del>	
		<b>Applicant</b> Fook-Luen Heng, et al.			
		<b>Filing Date</b> <del>Herewith</del> 02/10/2004		<b>Group</b> AU2825 <del>Unassigned</del>	

  

U.S. PATENT DOCUMENTS							
EXAMINER INITIAL*	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE (if appropriate)	
TT	AA	4,805,113	2/14/99	Ishii, et al.			
TT	AB	5,416,722	5/16/95	Edwards			
TT	AC	5,515,293	5/7/96	Edwards			
TV	AD	5,568,396	10/22/96	Bamji, et al.			
TT	AE	5,581,474	12/3/96	Bamji, et al.			

  

EXAMINER INITIAL*	DOCUMENT NUMBER	Date	Country	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
TT	WO 01/65424 A2	9/7/01	PCT				

  

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)		
TT		J. L. Burns, et al., "Detection of Overconstraints in IC Layout Compaction", IBM Technical Disclosure Bulletin, Vol. 35, No. 4B, September 1992, Pages 466-469;
TT		J. Lee, "Systematic Formulation of Design Rules for Integrated Circuit Layouts", IBM Technical Disclosure Bulletin, Vol. 30, No. 7, December 1987, Pages 120-123; and
TT		David Marple, "A Hierarchy Preserving Hierarchical Compactor" in Proceedings of the 27th ACM/IEEE Design Automation Conference (1990), Page 375.

  

EXAMINER <i>Lynne W</i>	DATE CONSIDERED 05/28/2006
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\* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

**LIST OF REFERENCES  
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(Use several sheets if necessary)

**Atty. Docket No.**  
END920030090US1 (16992)

**Serial No.** 10/776,901  
Unassigned

**Applicant**  
Fook-Luen Heng, et al.

**Filing Date**  
Herewith 02/10/2004

**Group** AU 2825  
Unassigned

**U.S. PATENT DOCUMENTS**

EXAMINER INITIAL*		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE (if appropriate)
TT	AF	5,612,893	3/18/97	Hao, et al.			
TT	AG	5,764,532	6/9/98	Patel			
TT	AH	5,825,661	10/20/98	Drumm			
TT	AI	5,889,681	3/30/99	Suda			
TT	AJ	5,892,261	4/6/99	Lin, et al.			

		Foreign Document Number	Date	Country	CLASS	SUBCLASS	TRANSLATION	
							YES	NO

**OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)**


**EXAMINER** *Tracy W*

**DATE CONSIDERED** 05/28/2006

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Unassigned

**U.S. PATENT DOCUMENTS**

EXAMINER INITIAL*		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE (if appropriate)
TT	AK	6,434,721 B1	8/13/02	Chiluvuri, et a.			
	AL	X					
	AM						
	AN						
	AO						

		Foreign Document Number	Date	Country	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
		X						

**OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)**

		X

EXAMINER *Tracy Tw*

DATE CONSIDERED 05/28/2006

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